

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/765,919	HATAKEYAMA ET AL.	
Examiner	Art Unit	
Sin J. Lee	1752	

	SEARCHED					
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Structure Search for the Substituent 9P. of formula (1)	12-22 -05	SJL		
Structure search for the substituent gp. of formula (2)	12-22 -05			
Structure Search for the substituent 9p. of formula (3)	-05	•		
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